

IRFP244, IRFP245, IRFP246, IRFP247

15A and 14A, 275V and 250V, 0.28 and 0.34 Ohm,
N-Channel Power MOSFETs

July 1998

Features

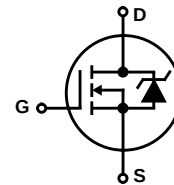
- 15A and 14A, 275V and 250V
- $r_{DS(ON)} = 0.28\Omega$ and 0.34Ω
- Single Pulse Avalanche Energy Rated
- SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance
- 275V, 250VDC Rated, 120VAC Line System Operation
- Related Literature
 - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

Description

These are N-Channel enhancement mode silicon gate power field effect transistors. They are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

Formerly developmental type TA17423.

Symbol



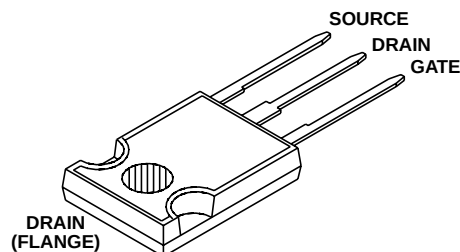
Ordering Information

PART NUMBER	PACKAGE	BRAND
IRFP244	TO-247	IRFP244
IRFP245	TO-247	IRFP245
IRFP246	TO-247	IRFP246
IRFP247	TO-247	IRFP247

NOTE: When ordering, include the entire part number.

Packaging

JEDEC STYLE TO-247



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Absolute Maximum Ratings $T_C = 25^{\circ}\text{C}$, Unless Otherwise Specified

	IRFP244	IRFP245	IRFP246	IRFP247	UNITS
Drain to Source Voltage (Note 1) V_{DS}	250	250	275	275	V
Drain to Gate Voltage ($R_{GS} = 20k\Omega$) (Note 1) V_{DGR}	250	250	275	275	V
Continuous Drain Current. I_D	15	14	15	14	A
$T_C = 100^{\circ}\text{C}$ I_D	9.7	8.8	9.7	8.8	A
Pulsed Drain Current (Note 3) I_{DM}	60	56	60	56	A
Gate to Source Voltage V_{GS}	± 20	± 20	± 20	± 20	V
Maximum Power Dissipation P_D	150	150	150	150	W
Linear Derating Factor	1.2	1.2	1.2	1.2	$W/^{\circ}\text{C}$
Single Pulse Avalanche Energy Rating (Note 4) E_{AS}	550	550	550	550	mJ
Operating and Storage Temperature T_J, T_{STG}	-55 to 150	-55 to 150	-55 to 150	-55 to 150	$^{\circ}\text{C}$
Maximum Temperature for Soldering					
Leads at 0.063in (1.6mm) from Case for 10s T_L	300	300	300	300	$^{\circ}\text{C}$
Package Body for 10s, See Techbrief 334 T_{pkg}	260	260	260	260	$^{\circ}\text{C}$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

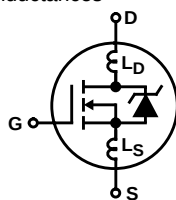
1. $T_J = 25^{\circ}\text{C}$ to 125°C .

Electrical Specifications $T_C = 25^{\circ}\text{C}$, Unless Otherwise Specified

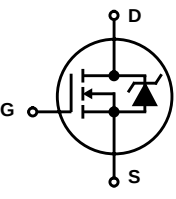
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage IRFP244, IRFP245	BV_{DSS}	$V_{GS} = 0V, I_D = 250\mu A$ (Figure 10)	250	-	-	V
IRFP246, IRFP247			275	-	-	V
Gate to Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu A$	2.0	-	4.0	V
Zero-Gate Voltage Drain Current	I_{DSS}	$V_{DS} = \text{Rated } BV_{DSS}, V_{GS} = 0V$	-	-	25	μA
		$V_{DS} = 0.8 \times \text{Rated } BV_{DSS}, V_{GS} = 0V$ $T_J = 125^{\circ}\text{C}$	-	-	250	μA
On-State Drain Current (Note 2) IRFP244, IRFP246	$I_{D(ON)}$	$V_{DS} > I_{D(ON)} \times r_{DS(ON)MAX}, V_{GS} = 10V$ (Figure 7)	15	-	-	A
IRFP245, IRFP247			14	-	-	A
Gate to Source Leakage	I_{GSS}	$V_{GS} = \pm 20V$	-	-	± 100	nA
Drain to Source On Resistance (Note 2) IRFP244, IRFP246	$r_{DS(ON)}$	$V_{GS} = 10V, I_D = 10A$ (Figures 8, 9)	-	0.20	0.28	Ω
IRFP245, IRFP247			-	0.24	0.34	Ω
Forward Transconductance (Note 2)	g_{fs}	$V_{DS} \geq 50V, I_D = 10A$ (Figure 12)	6.7	11	-	S
Turn-On Delay Time	$t_{d(ON)}$	$V_{DD} = 125V, I_D \approx 15A, R_G = 9.1\Omega, V_{GS} = 10V,$ $R_L = 8\Omega$ (Figures 17, 18) MOSFET Switching Times are Essentially Independent of Operating Temperature	-	16	24	ns
Rise Time	t_r		-	67	100	ns
Turn-Off Delay Time	$t_{d(OFF)}$		-	53	80	ns
Fall Time	t_f		-	49	74	ns
Total Gate Charge (Gate to Source + Gate to Drain)	$Q_{g(TOT)}$	$V_{GS} = 10V, I_D = 15A, V_{DS} = 0.8 \times \text{Rated } BV_{DSS},$ $I_{G(REF)} = 1.5mA$ (Figures 14, 19, 20) Gate charge is Essentially Independent of Operating Temperature	-	39	59	nC
Gate to Source Charge	Q_{gs}		-	6.6	-	nC
Gate to Drain "Miller" Charge	Q_{gd}		-	20	-	nC

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Electrical Specifications $T_C = 25^\circ\text{C}$, Unless Otherwise Specified (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Input Capacitance	C _{ISS}	V _{GS} = 0V, V _{DS} = 25V, f = 1.0MHz (Figure 11)		-	1300	-	pF
Output Capacitance	C _{OSS}			-	320	-	pF
Reverse Transfer Capacitance	C _{RSS}			-	69	-	pF
Internal Drain Inductance	L _D	Measured fRom the Drain Lead, 6mm (0.25in) From Pack- age to the Center of Die	Modified MOSFET Symbol Showing the Internal Devices Inductances 	-	5.0	-	nH
Internal Source Inductance	L _S	Measured from The Source Lead, 6mm (0.25in) from the Header to the Source Bonding Pad		-	12.5	-	nH
Junction to Case	R _{θJC}			-	-	0.83	°C/W
Junction to Ambient	R _{θJA}	Free Air Operation		-	-	30	°C/W

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I_{SD}	Modified MOSFET Symbol Showing the Integral Reverse P-N Junction Diode 		-	-	15	A
Pulse Source to Drain Current (Note 3)	I_{SDM}			-	-	60	A
Source to Drain Diode Voltage (Note 2)	V_{SD}	$T_J = 25^\circ\text{C}$, $I_{SD} = 15\text{A}$, $V_{GS} = 0\text{V}$ (Figure 13)		-	-	1.8	V
Reverse Recovery Time	t_{rr}	$T_J = 25^\circ\text{C}$, $I_{SD} = 14\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$		150	300	640	ns
Reverse Recovered Charge	Q_{RR}	$T_J = 25^\circ\text{C}$, $I_{SD} = 14\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$		1.6	3.4	7.2	μC

NOTES:

- Pulse test: pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
- Repetitive rating: pulse width limited by Max junction temperature. See Transient Thermal Impedance curve (Figure 3).
- $V_{DD} = 50\text{V}$, starting $T_J = 25^\circ\text{C}$, $L = 4.0\mu\text{H}$, $R_G = 25\Omega$, peak $I_{AS} = 15\text{A}$. See Figures 15, 16.

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Typical Performance Curves Unless Otherwise Specified

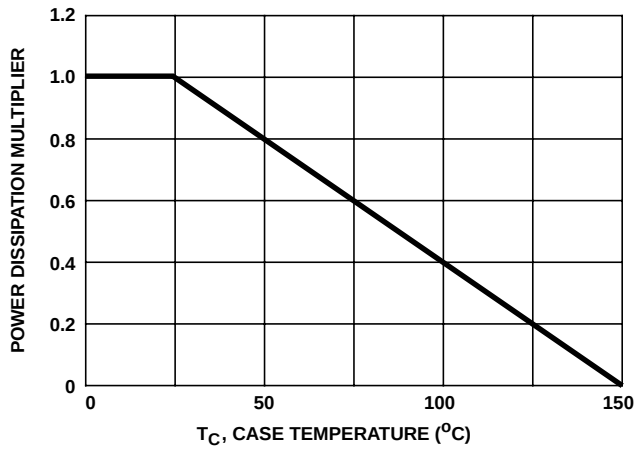


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

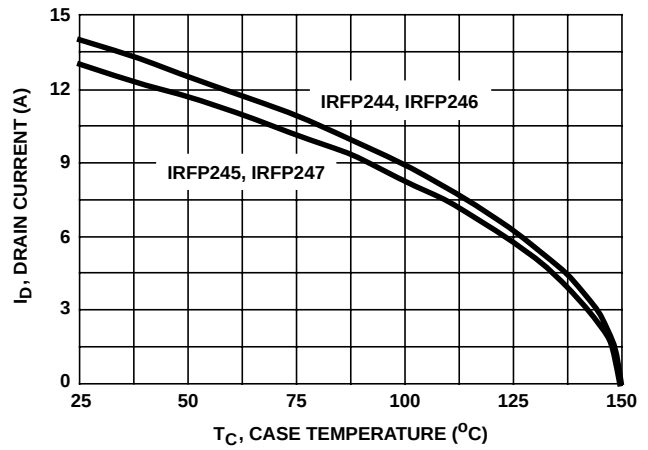


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

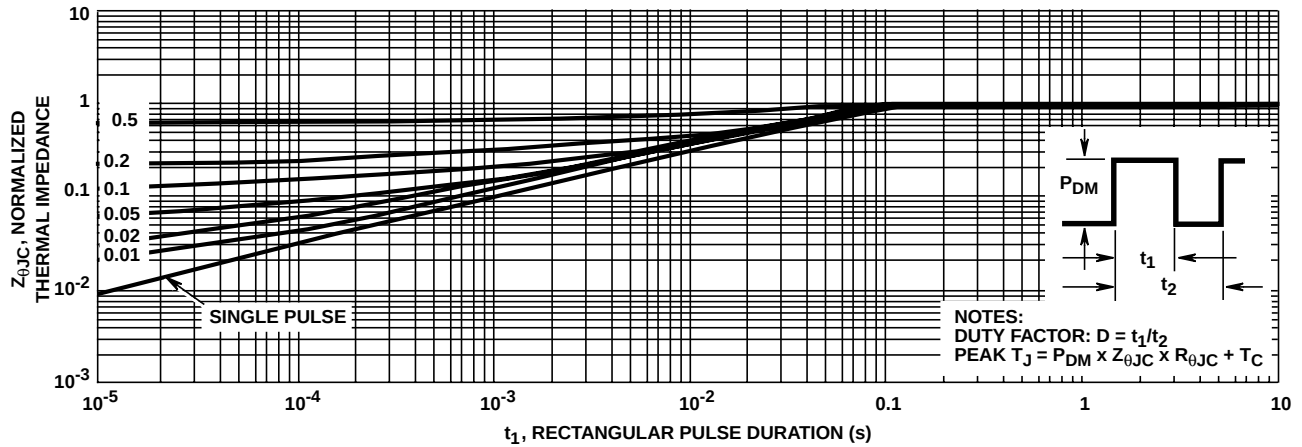


FIGURE 3. NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE

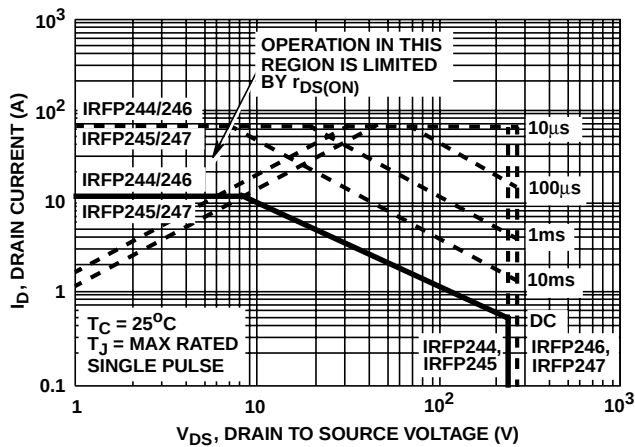


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

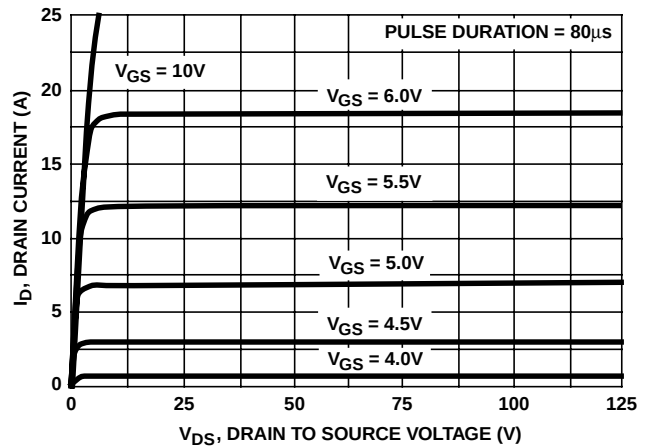


FIGURE 5. OUTPUT CHARACTERISTICS

Typical Performance Curves Unless Otherwise Specified (Continued)

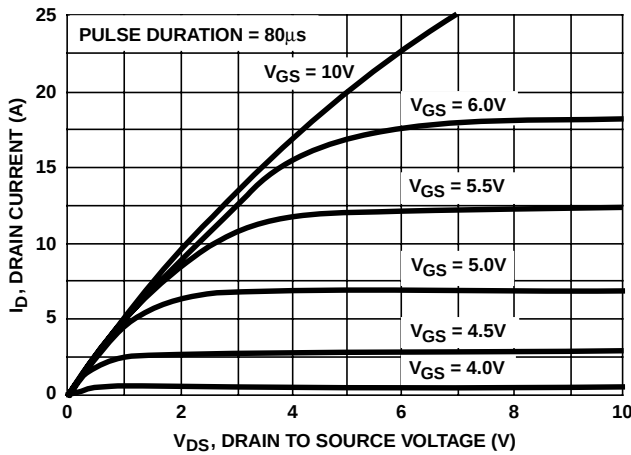


FIGURE 6. SATURATION CHARACTERISTICS

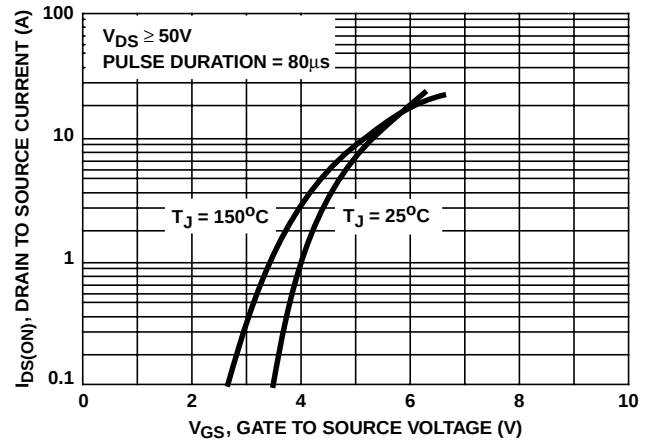
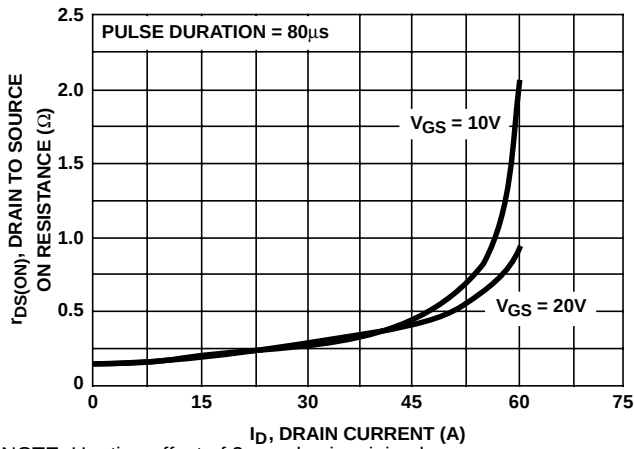


FIGURE 7. TRANSFER CHARACTERISTICS



NOTE: Heating effect of 2 μ s pulse is minimal.

FIGURE 8. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

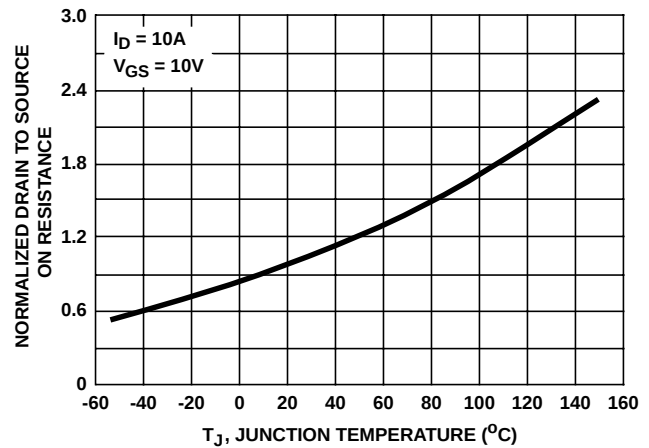


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

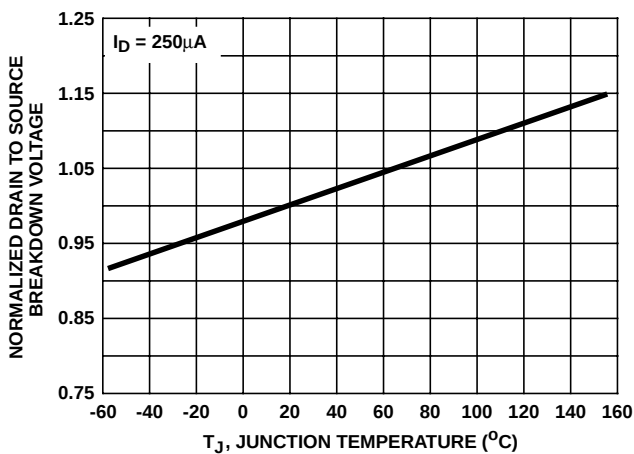


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

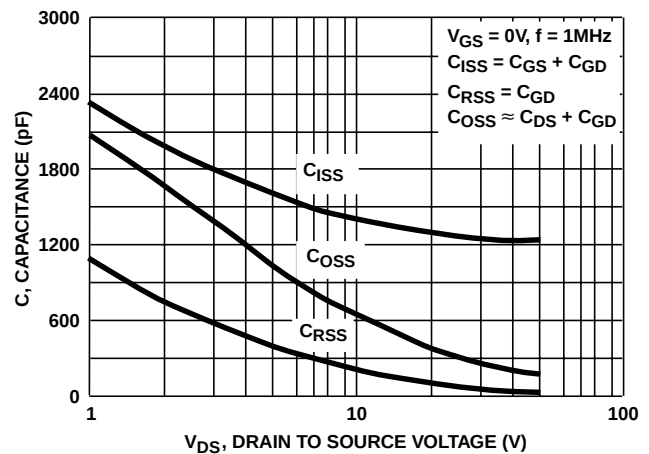


FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

Typical Performance Curves Unless Otherwise Specified (Continued)

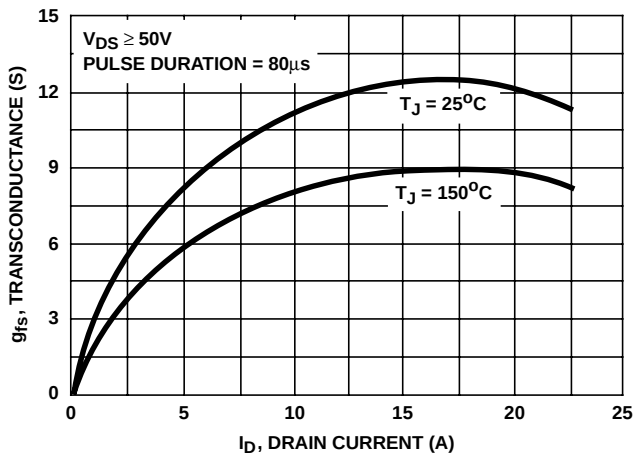


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

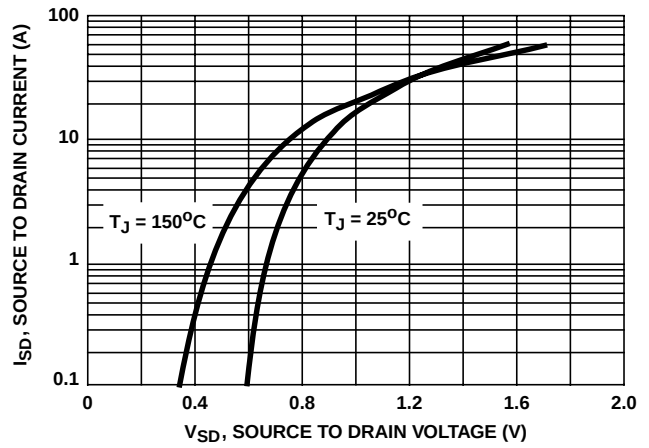


FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

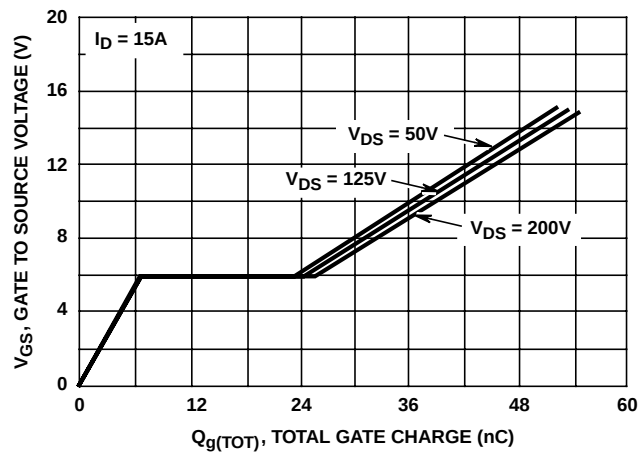


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

Test Circuits and Waveforms

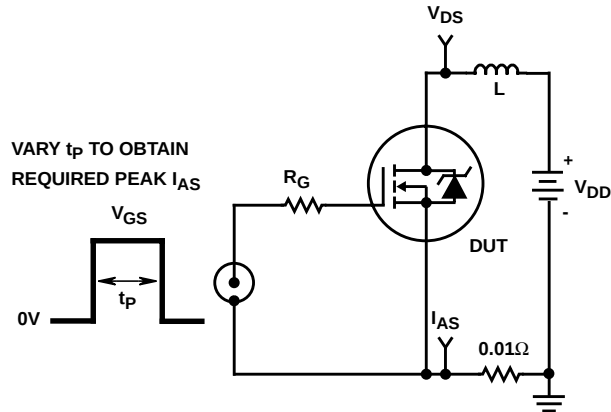


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

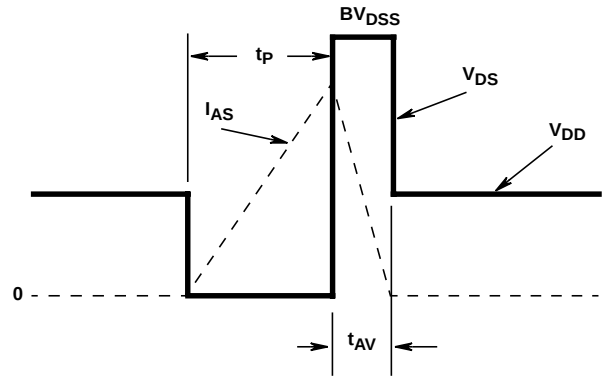


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

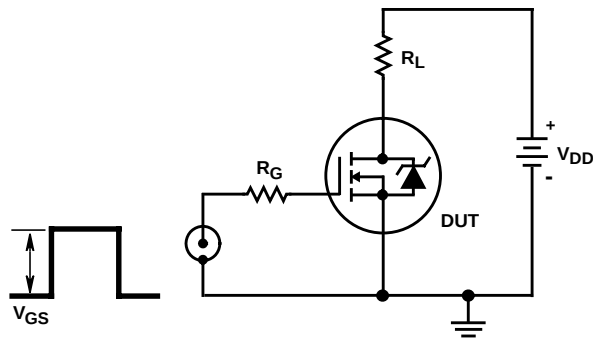


FIGURE 17. SWITCHING TIME TEST CIRCUIT

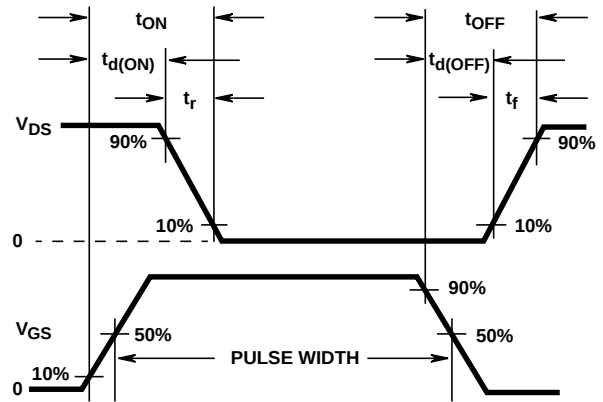


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

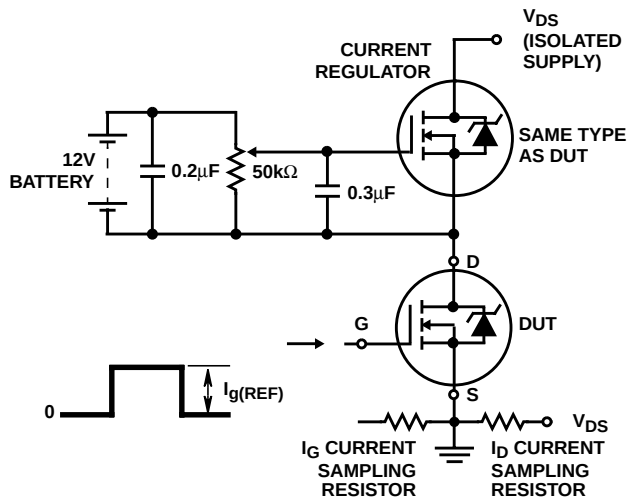


FIGURE 19. GATE CHARGE TEST CIRCUIT

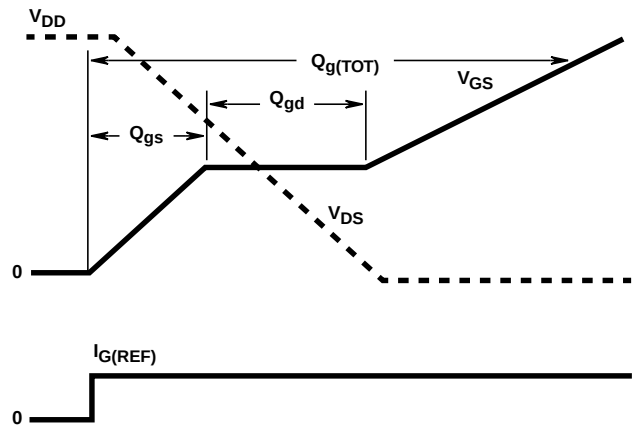


FIGURE 20. GATE CHARGE WAVEFORMS